

SEARCHED

[illegible]

INTERFERENCE SEARCHED

Class	Sub.	Date	Exmr.

SEARCH NOTES

(INCLUDING SEARCH STRATEGY)

	Date	Exmr.
inspected app. # 08/821,468	5/18/01	TM
EAST	5/19/01	TM
"Fabricating interconnect semiconductor die"		
"Wafer 'opening'"		
"insulated #3 conductive"	↓	↓
08/821,468 checked references	2/7/02	TM